

Notice of References Cited	Application/Control No. 09/525,105	Applicant(s)/Patent Under Reexamination ABBOTT ET AL.
	Examiner Alexander O Williams	Art Unit 2826

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5360991	11-1994	Abys et al.	257	666
	B	US-4754317	06-1988	Comstock et al.	--	--
	C	US-4137546	01-1979	Frusco	--	--
	D	US-5234866	08-1993	Okinaga et al.	--	--
	E	US-6232651B1	05-2001	Lee et al.	257	666
	F	US-6287896B1	09-2001	Yeh et al.	438	123
	G	US-6245448B1	06-2001	Abbott	257	677
	H	US-6087712	07-2000	Kim et al.	257	66
	I	US-				
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	K	US-				
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	M	US-				

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	2000-77593	03-2000	Japan	Akino et al.	--	--
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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